

<b>LIST OF REFERENCES CITED BY APPLICANT</b>  (Use several sheets if necessary)		ATTY DOCKET NO. 618-1018	APPLICATION NO 10/085,100
		APPLICANT Enric AMOROS et al.	
		FILING DATE March 1, 2002	GROUP 3743

*O I P E JCT. FEB 20 2003 PATENT & TRADEMARK OFFICE*

**U.S. PATENT DOCUMENTS**

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MP	AA	5,059,852	10/22/1991	Meury	310	339	
MB	AB	4,608,508	08/26/1986	Ohnishi	310	339	
AC							
AD							
AE							
AF							
AG							
AH				RECEIVED FEB 24 2003 TECHNOLOGY CENTER R3700			
AI							

**FOREIGN PATENT DOCUMENTS**

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
MP	AJ	JP 11-63498	03/05/1999	Japan w/Eng. Abstract			YES NO
MB	AK	JP 05-66014	03/19/1993	Japan w/Eng. Abstract			
AL							
AM							
AN							
AO							

**OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)**

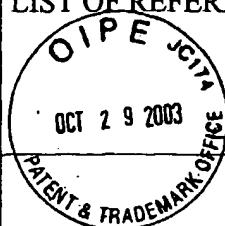
	AP	
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EXAMINER <i>MARIA U. RUDD</i> PRIMARY EXAMINER OPT-HNT 910	DATE CONSIDERED <i>9-22-04</i>
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Sheet 1 of 1

OCT 30 2003  
Group 3700ATTY DOCKET NO.  
618-1018APPLICATION NO.  
10/085,100APPLICANT  
Enric AMOROS et al.FILING DATE  
March 1, 2002GROUP  
3743LIST OF REFERENCES CITED BY APPLICANT  
(Use several sheets if necessary)

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*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MB	A01	3,829,737	8/13/1974	Johnsson	317	81	
	A02						
	A03						
	A04						
	A05						
	A06						
	A07						
	A08						
	A09						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	YES	NO
.	B01								
.	B02								
.	B03								
.	B04								
.	B05								

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

C01	
C02	
C03	

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EXAMINER	MARK J BUDD PRIMARY EXAMINER	DATE CONSIDERED
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9-22-04

ART UNIT 212

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<p style="text-align: center;"><b>O P F</b> <b>LIST OF REFERENCES CITED BY APPLICANT</b> (Use several sheets if necessary)</p> <p>NOV 04 2002</p>				ATTY. DOCKET NO.	APPLICATION NO.		
				618-1018	10/085,100		
				APPLICANT			
				Enric AMOROS et al.			
				FILING DATE	GROUP		
				March 1, 2002	3743		
<b>U.S. PATENT DOCUMENTS</b>							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
JB	AA	US 2002/0136996	9/26/02	Ichikawa et al.	431	153	
JB	AB	6,106,277	8/22/00	Xie	431	153	
	AC						
	AD						
	AE						
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	AG						
	AH						
	AI						
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
							YES NO
JB	AJ	JP 2002-54814	2/20/02	Japan w/Eng. Abstract			
JB	AK	JP 2001-343122	12/14/01	Japan w/Eng. Abstract			
	AL						
	AM						
	AN						
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)</b>							
	AO						
	AP						
	AQ						
EXAMINER M. U. BUDD PRIMARY EXAMINER				DATE CONSIDERED		9-22-04	
ART UNIT 217 *EXAMINER: Initial if reference considered; whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

				ATTY. DOCKET NO. 618-1018	APPLICATION NO. 10/085,100
LIST OF REFERENCES CITED BY APPLICANT <i>(Use several sheets if necessary)</i>				APPLICANT Enric AMOROS et al.	
MAY 09 2002 JC/8				FILING DATE March 1, 2002	GROUPE 3743
U.S. PATENT DOCUMENTS					
EXAMINER'S TRADE MARK REFERENCE INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS
MM	AA 6,116,892	09/2000	Yang	431	153
	AB 6,106,277	08/2000	Xie	431	153
	AC 6,102,689	08/2000	Man	431	153
	AD 6,099,298	08/2000	Potskhishvili et al.	431	153
	AE 6,099,297	08/2000	Chan	431	153
	AF 6,099,296	08/2000	Wang	431	153
	AG 6,095,796	08/2000	Sung	431	153
	AH 6,095,795	08/2000	Potskhishvili et al.	431	153
	AI 6,086,359	07/2000	Sher	431	153
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	AK 6,077,071	06/2000	Yeh	431	153
	AL 6,077,070	06/2000	Doucet et al.	431	153
	AM 6,077,069	06/2000	Fairbanks et al.	431	153
	AN 6,074,198	06/2000	Rogelet	431	153
	AO 6,065,958	05/2000	Adams et al.	431	153
	AP 6,046,528	04/2000	LaForest et al.	310	339
	AQ 6,045,354	04/2000	McDonough et al.	431	153
	AR 6,010,328	01/2000	Sung	431	153
	AS 5,980,239	11/1999	Doucet et al.	431	153
	AT 5,927,962	07/1999	Amoros Nollas et al.	431	255
	AU 5,854,530	12/1998	LaForest et al.	310	339
	AV 5,788,474	08/1998	Chung et al.	431	153
	AW 5,642,993	07/1997	McDonough et al.	431	153
	AX 5,636,979	06/1997	McDonough et al.	431	153
	AY 5,628,627	05/1997	Fairbanks et al.	431	153
	AZ 5,584,682	12/1996	McDonough et al.	431	153
	BA 5,487,657	01/1996	Fairbanks et al.	431	153
	BB 5,435,719	07/1995	McDonough et al.	431	153
EXAMINER MARK U. SIEGEL			DATE CONSIDERED 9-22-04		
PRIMARY EXAMINER					
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<p style="text-align: center;"><b>LIST OF REFERENCES CITED BY APPLICANT</b>  <i>(Use several sheets if necessary)</i></p> <p style="text-align: center;">MAY 09 2002 JC78</p>				ATTY. DOCKET NO.	APPLICATION NO.		
				618-1018	10/085,100		
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March 1, 2002	3743						
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*EXAMINER'S INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
MS	BC 5,417,571	05/1995	Kvalseth	431	153		
	BD 5,417,563	05/1995	Cirami	431	153		
	BE 5,262,697	11/1993	Meury	310	339		
	BF 5,240,408	08/1993	Kenjiro et al.	431	153		
	BG 5,215,458	06/1993	Cirami	431	277		
	BH 5,178,532	01/1993	Frigiere	431	254		
	BI 5,171,143	12/1992	Sohn	431	153		
	BJ 5,125,829	06/1992	McDonough et al.	431	255		
	BK 5,092,764	03/1992	McDonough et al.	431	277		
	BL 5,059,852	10/1991	Meury	310	339		
	BM 5,035,608	07/1991	Parren	431	153		
	BN 5,002,482	03/1991	Fairbanks et al.	431	277		
	BO 4,830,603	05/1989	Cirami	431	153		
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	BS 3,883,289	05/1975	Fujioka	431	131		
	BT 3,817,691	06/1974	Tatsumi	431	255		
	BU 3,734,680	05/1973	Maruyama	431	132		
	BV 3,540,823	11/1970	Ebine et al.	431	255		
↓	BW 3,457,461	07/1969	Steinke et al.	317	81		
<b>FOREIGN PATENT DOCUMENTS</b>							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
MS	BX 6-249438	09/1994	Japan			X	Abs
MS	BY 60-89625	05/1985	Japan			X	Abs
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)</b>							
	BZ						
EXAMINER <i>MARK B. BUDD</i> PRIMARY EXAMINER				DATE CONSIDERED <i>9-72-04</i>			
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